


<b>Search Notes</b>  	<b>Application/Control No.</b>  10815231	<b>Applicant(s)/Patent Under Reexamination</b>  FAUNCE ET AL.
	<b>Examiner</b>  Ahn, Sangwoo	<b>Art Unit</b>  2166

SEARCHED			
Class	Subclass	Date	Examiner
707	2- (text search only)3	8/14/2007	SW

SEARCH NOTES		
Search Notes	Date	Examiner
EAST UPDATE (US-PGPUB, USPAT, EPO, JPO, DERWENT, IBM_TDB)	8/14/2007	SW
Consulted Khanh Pham	8/14/2007	SW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
707	2	8/14/2007	SW
707	3	8/14/2007	SW